

FQB5N50CF 500V N-Channel MOSFET

Features

- 5A, 500V, $R_{DS(on)} = 1.55 \Omega @V_{GS} = 10 V$
- Low gate charge (typical 18nC)
- Low Crss (typical 15pF)
- · Fast switching
- 100% avalanche tested
- Improved dv/dt capability



These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

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This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, electronic lamp ballasts based on half bridge topology.

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Absolute Maximum Ratings

Symbol	Parameter	FQB5N50CF	Units	
V _{DSS}	Drain-Source Voltage	500	V	
I _D	Drain Current - Continuous ($T_C = 25^{\circ}C$)	5	А	
	- Continuous (T _C = 100°C)		3.2	А
I _{DM}	Drain Current - Pulsed	(Note 1)	20	А
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	300	mJ
I _{AR}	Avalanche Current	(Note 1)	5	A
E _{AR}	Repetitive Avalanche Energy	(Note 1)	9.6	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.5	V/ns
P _D	Power Dissipation ($T_c = 25^{\circ}C$)		96	W
	- Derate above 25°C		0.76	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to +150	°C	
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	FQB5N50CF	Units
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction-to-Case	1.3	°C/W
R_{\thetaJA}	Thermal Resistance, Junction-to-Ambient*	40	°C/W
R_{\thetaJA}	Thermal Resistance, Junction-to-Ambient	62.5	°C/W

* When mounted on the minimum pad size recommended (PCB Mount)

Device Marking		Device	Packag	e Re	e Reel Size Tap		e Width		Quantity	
FQB5N50CF		FQB5N50CFTM	D2-PAK		330mm 2		24mm		800	
FQB5N50CF FQB5N50CFTF D2-F		D2-PAK	330mm		24mm		800			
Electric	al Char	racteristics Tc	= 25°C unless othe	rwise noted						
Symbol		Parameter			Conditior	IS	Min	Тур	Max	Units
Off Charac	teristics			<u> </u>					ļ	
BV _{DSS}	Drain-Sou	Irce Breakdown Voltag	ge	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$			500			V
ΔΒV _{DSS} / ΔT _J	Breakdow	reakdown Voltage Temperature Coefficient		$I_D = 250 \ \mu$ A, Referenced to 25°C				0.5		V/°C
	Zero Gate	Zero Gate Voltage Drain Current		$V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}$				10	μA	
				V _{DS} = 400 V, T _C = 125°C					100	μA
I _{GSSF}	Gate-Bod	y Leakage Current, Fe			/ _{DS} = 0 V				100	nA
I _{GSSR}	Gate-Bod	y Leakage Current, R	everse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$				-100	nA	
On Charact	eristics									
V _{GS(th)}	Gate Thre	Threshold Voltage		$V_{DS} = V_{GS}, I_D = 250 \ \mu A$			2.0		4.0	V
R _{DS(on)}	Static Dra	in-Source On-Resista	nce	V _{GS} = 10 V, I _D = 2.5A			1.3	1.55	Ω	
9fs	Forward 7	Fransconductance	onductance V		$I_{\rm DS} = 40$ V, $I_{\rm D} = 2.5$ A (Note 4)			5.2		S
Dynamic Cł	naracteristi	cs								
C _{iss}	Input Cap	acitance		$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz				480	625	pF
C _{oss}	Output Ca	apacitance					80	105	pF	
C _{rss}	Reverse 7	Fransfer Capacitance						15	20	pF
Switching C	haracterist	ics								
t _{d(on)}	Turn-On Delay Time		$V_{DD} = 250 \text{ V}, \text{ I}_{D} = 5\text{A},$			12	35	ns		
t _r	Turn-On F	Rise Time		R _G = 25 Ω				46	100	ns
t _{d(off)}	Turn-Off	Delay Time						50	110	ns
t _f	Turn-Off F	all Time				(Note 4, 5)		48	105	ns
Qg	Total Gate	e Charge			V _{DS} = 400 V, I _D = 5A,			18	24	nC
Q _{gs}	Gate-Sou	rce Charge		V _{GS} = 10 V				2.2		nC
Q _{gd}	Gate-Drai	n Charge		(Note 4, 5				9.7		nC
Drain-Sourc	ce Diode C	haracteristics and Max	kimum Ratings							
I _S	Maximum	Continuous Drain-So	urce Diode Fo	rward Current					5	А
I _{SM}	Maximum	Pulsed Drain-Source	Diode Forward	orward Current					20	А
V _{SD}	Drain-Sou	urce Diode Forward Vo	oltage	$V_{GS} = 0 V, I_S$	= 5 A				1.4	V
t _{rr}	Reverse F	Recovery Time		$V_{GS} = 0 V, I_S$				65		ns
Q _{rr}	Reverse F	Recovery Charge				(Note 4)		110		nC

NOTES:

1. Repetitive Rating : Pulse width limited by maximum junction temperature

2. L = 21.5mH, I_{AS} = 5A, V_DD = 50V, R_G = 25 $\Omega,$ Starting $\ T_J$ = 25°C

3. $I_{SD} \leq$ 5A, di/dt \leq 200A/µs, $V_{DD} \leq BV_{DSS},$ Starting $\ T_J$ = 25°C

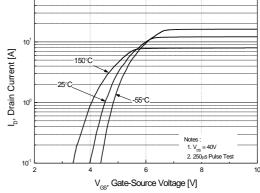
4. Pulse Test : Pulse width $\leq 300 \mu s,$ Duty cycle $\leq 2\%$

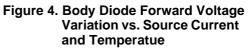
5. Essentially independent of operating temperature

Figure 1. On-Region Characteristics V_{cs} 15.0 V 10.0 V 8.0 V 7.0 V 6.5 V 6.5 V 5.5 V 10 10 Drain Current [A] I_D, Drain Current [A] 10 10 _____ 10 1. 250μs Pulse⁻ 2. Τ_c = 25°C 10⁻¹ 10¹ 10 10 V_{DS}, Drain-Source Voltage [V] Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage 4.5 4.0 10 R_{DS(ON)} [Ω], Drain-Source On-Resistance Reverse Drain Current [A] 3.5 = 10\ 3.0 2.5 10 2.0 $V_{GS} = 20V$ 1.5 DR' 1.0 Note : T, = 25°C 0.5 10⁻¹ 0 10 15 5 I_D, Drain Current [A] **Figure 5. Capacitance Characteristics** 1200 12 $C_{lss} = C_{gs} + C_{gd} (C_{ds} = shorted)$ $C_{arr} = C_{dr} + C_{arr}$ $C_{rss} = C_{gc}$ 1000 10 Gate-Source Voltage [V] 800 ۶ Capacitance [pF] 600 6 400 Notes ; 1. V_{GS} = 0 V 2. f = 1 MHz ر _{GS}, ر 200 2 0 0 10 10 10 V_{DS}, Drain-Source Voltage [V]

Typical Performance Characteristics

Figure 2. Transfer Characteristics





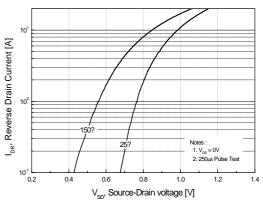
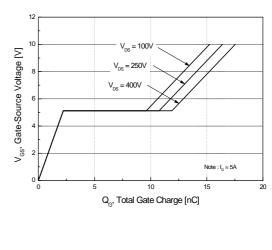
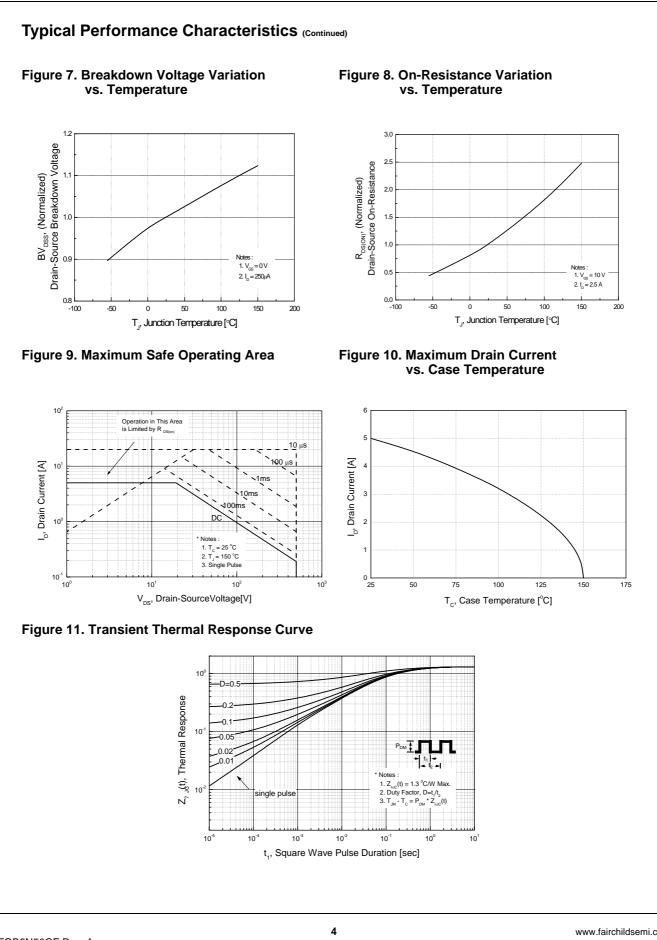
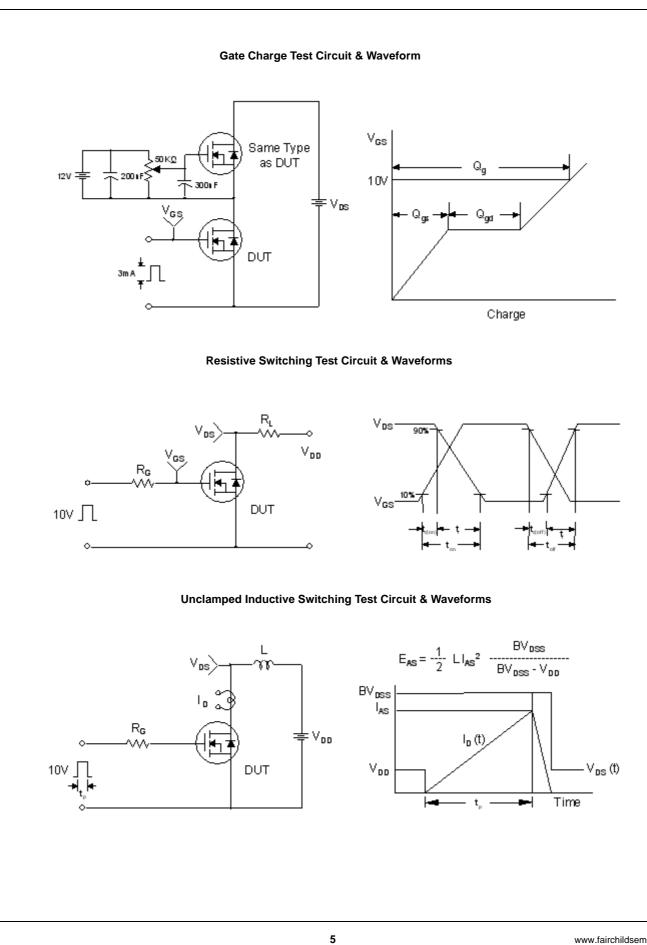
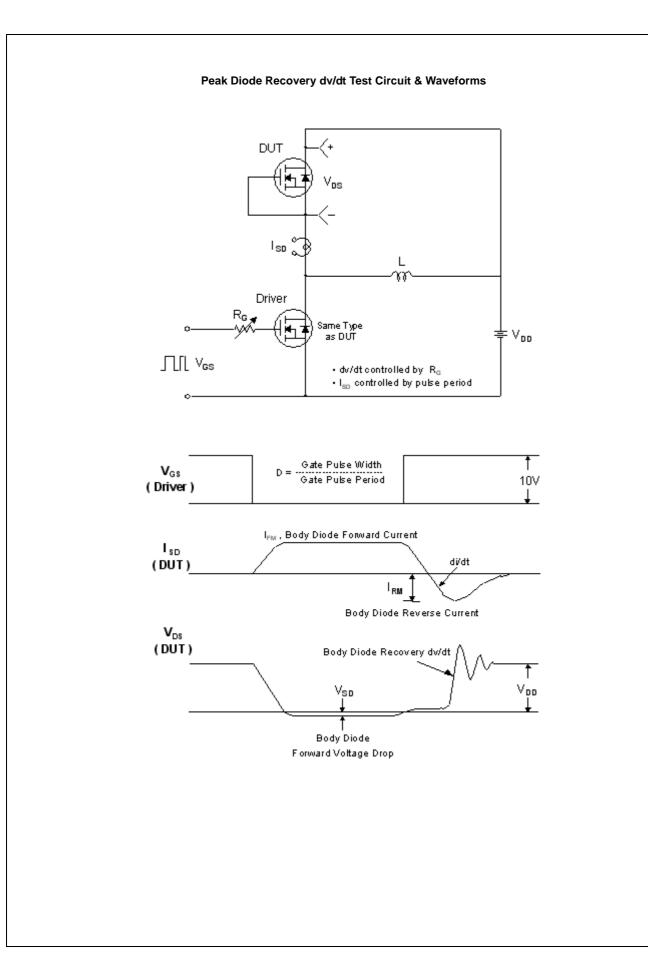


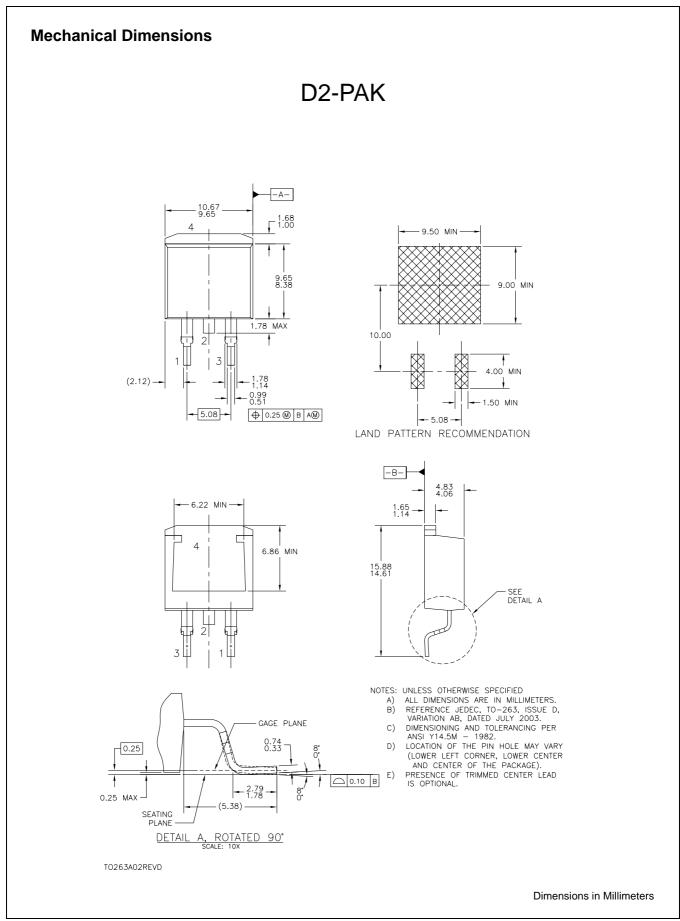
Figure 6. Gate Charge Characteristics











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